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Enter keywords or phrases, select fields, and select operators

<input type="text"/>	in All Fields	<input type="button" value="▼"/>	
AND <input type="button" value="▼"/>	<input type="text"/>	in All Fields	<input type="button" value="▼"/>
AND <input type="button" value="▼"/>	<input type="text"/>	in All Fields	<input type="button" value="▼"/>
<input type="button" value="Search"/> <input type="button" value="Reset"/>			

**(3) OPTION 2**

Enter keywords, phrases, or a Boolean expression

<input type="text" value="transition delay fault and top-off stuck-at fault"/>	<input type="button" value="▼"/>
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» Note: You may use the search operators <and> or <or> without the start and end brackets <>.

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